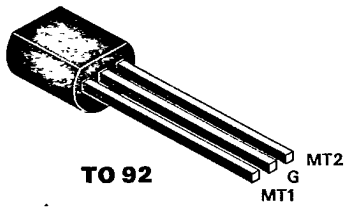
TAG SEMICONDUCTORS LTD

Z0105BA – Z0105NA TRIACS

1.0 A 200–800 V 5/5/5/5 mA



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The Z0105 series of TRIAC's are high performance PNPN devices diffused with TAG's proprietary Top Glass™ Process. These parts are intended for general purpose applications where logic compatible gate sensitivity is required.

Absolute Maximum Ratings $T_A = 25\,°C$ unless otherwise noted

Parameter	Part Nr.	Symbol	Min.	Max.	Unit	Test Conditions
Repetitive Peak Off State Voltage	**Z0105BA**	V_{DRM}	200		V	
	Z0105DA		400		V	$T_j = -40\,°C$ to $125\,°C$, $R_{GK} = 1\,K\Omega$
	Z0105MA		600		V	
	Z0105NA		800		V	
On-State Current		$I_{T(RMS)}$	0.8		A	All Conduction Angles $T_C = 50\,°C$
Nonrept. On-State Current		I_{TSM}	22		A	Half Cycle, 60 Hz
Nonrept. On-State Current		I_{TSM}	20		A	Half Cycle, 50 Hz
Fusing Current		I^2t	2		A^2s	t = 10 ms
Peak Reverse Gate Voltage		V_{GRM}	8		V	
Peak Gate Current		I_{GM}	1.2		A	10µs max.
Peak Gate Dissipation		P_{GM}	3		W	10µs max.
Gate Dissipation		$P_{G(AV)}$	0.2		W	20 ms max.
Operating Temperature		T_j	−40	125	°C	
Storage Temperature		T_{stg}	−40	150	°C	
Soldering Temperature		T_{sld}		250	°C	1.6 mm from case, 10 s max.

Electrical Characteristics $T_A = 25\,°C$ unless otherwise noted

Parameter	Symbol	Min.	Max.	Unit	Test Conditions
Off-State Leakage Current	I_{DRM}		200	µA	$V_D = V_{DRM}$ $R_{GK} = 1\,K\Omega$ $T_j = 125\,°C$
Off-State Leakage Current	I_{DRM}		5	µA	$V_D = V_{DRM}$ $R_{GK} = 1\,K\Omega$ $T_j = 25\,°C$
On-State Voltage	V_T		1.26	V	at $I_T = 1.2$ A, $T_j = 25\,°C$
On-State Threshold Voltage	$V_{T(TO)}$		0.95	V	$T_j = 125\,°C$
On-State Slope Resistance	r_T		200	mΩ	$T_j = 125\,°C$
Gate Trigger Current	I_{GT} I+ (1)		5	mA	$V_D = 12$ V
	I_{GT} I− (2)		5	mA	$V_D = 12$ V
	I_{GT} III− (3)		5	mA	$V_D = 12$ V
	I_{GT} III+ (4)		5	mA	$V_D = 12$ V
Gate Trigger Voltage	V_{GT}		2	V	$V_D = 12$ V All Quadrants
Holding Current	I_H		5	mA	$R_{GK} = 1\,K\Omega$
Critical Rate of Voltage Rise	dv/dt	30		V/µs	$V_D = .67 \times V_{DRM}$ $R_{GK} = 1\,K\Omega$ $T_j = 125\,°C$
Critical Rate of Rise, Off-State	dv/dt_c	1		V/µs	$I_T = 0.8$ A di/dt = 0.35 A/ms $T_C = 50\,°C$
Gate Controlled Delay Time	t_{gd}		2.5	µs	$I_G = 25$ mA $di_G/dt = 0.25$ A/µs
Thermal Resistance junc. to case	$R_{\Theta jc}$		90	K/W	
Thermal Resistance junc. to amb.	$R_{\Theta ja}$		180	K/W	

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